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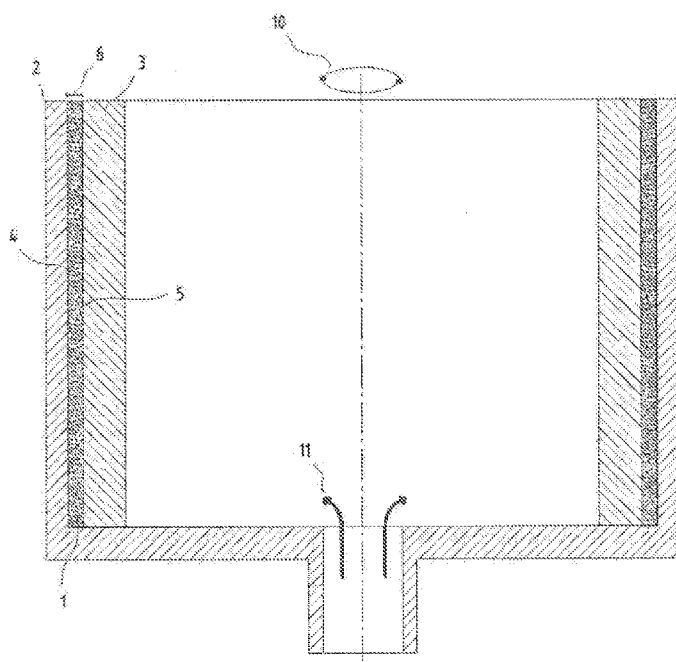
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(54) Title: REACTOR AND METHOD FOR PRODUCTION OF SILICON BY CHEMICAL VAPOR DEPOSITION

FIG. 1



(57) Abstract: The invention provides a reactor for the manufacture of silicon by chemical vapour deposition (CVD), the reactor comprises a reactor body that can rotate around an axis with the help of a rotation device operatively arranged to the reactor, at least one sidewall that surrounds the reactor body, at least one inlet for reaction gas, at least one outlet for residual gas and at least one heat appliance operatively arranged to the reactor. The reactor is characterised in that during operation for the manufacture of silicon by CVD, the reactor comprises a layer of particles on the inside of, at least, one sidewall.

REACTOR AND METHOD FOR PRODUCTION OF SILICON
BY CHEMICAL VAPOR DEPOSITION

Field of the invention

5 The present invention relates to the manufacture of silicon for application in sun cells and electronics. In more detail, the invention relates to a reactor and a method for production of silicon, in particular the deposition surface of a rotating reactor for manufacture of silicon by chemical vapour deposition, CVD.

10 Background of the invention and prior art

The development of new methods to use renewable, non-polluting energy sources is essential to meet future needs for energy. Energy from the sun is one of the energy sources which are of the greatest interest in this context.

15 Silicon is a critical raw material for both the electronics industry and the solar cell industry. Although there are alternative materials for specific applications, multi-crystalline and mono-crystalline silicon will be the material of choice for the foreseeable future. Improved availability and economics of production of multi-crystalline silicon will increase the growth possibilities for both these industries,
20 in particular the application of solar cells for renewable energy.

Currently, to manufacture silicon of a satisfactory purity for use in solar cells or electronics, chemical vapour deposition methods (CVD – Chemical Vapour
Deposition) are primarily used. Different embodiments of the Siemens process
25 are the most used forms of CVD for the manufacture of polycrystalline silicon. In this method, silicon containing gases, such as silane or trichlorosilane, and other gases such as hydrogen and argon, are fed into a cooled container and silicon is deposited on one or more resistance-heated rods. The process is very energy and labour demanding. A more detailed description of the most used
30 process can be found in the patent US 3,979,490.

Another CVD method uses a fluidized bed, whereby silicon seed particles are fluidised and held in an upward flowing gas stream, with the gas stream comprising silicon-containing gas from which silicon can be deposited onto the seed particles. A full description of CVD methods with a fluidised bed and associated equipment and operating parameters for the manufacture of silicon, including gas mixtures, temperatures for the deposition and related problems and limitations can be found in the patents US 4,818,495 and US 5,810, 934, and reference is given to these publications for more information.

10 A rotating CVD reactor has been developed and a patent has been applied for by Dynatec Engineering with the patent applications NO 2009 2111 and NO 2010 0210. A reactor for the manufacture of silicon by chemical vapour deposition is thus provided, with the reactor comprising a reactor body that forms a container, with at least one inlet for a silicon-containing gas, at least one outlet and at least one heat appliance as a part of, or operatively arranged to, the reactor. In one main embodiment the reactor is characterised in that it rotates so that the reaction gas is subjected to centripetal acceleration. In the following, such a reactor is designated as a Dynatec reactor.

20 The principle for a Dynatec reactor is that a silicon-containing gas, preferably silane, is fed into a rotating, heated container. The difference in density between the reaction gas and the residual gas makes it possible to separate the gases with the help of the centripetal acceleration. The heavy reaction gas is forced out from the centre of the container, whereupon it decomposes when it is heated up by the inner wall of the container, whereupon silicon is deposited. This gives a higher rate of deposition and a better utilisation of the reaction gas, at the same time as the need for selective cooling of surfaces where the decomposition shall not occur is minimised. Together, this reduces the energy consumption per kilo produced silicon. However, there is a need for further improvement of the Dynatec reactor to lower the cost per produced kg super-clean silicon further and the aim of the present invention is to provide a such improvement.

30

Summary of the invention

The invention provides a reactor for the manufacture of silicon by chemical vapour deposition (CVD), the reactor comprises a reactor body that can be
5 vapour deposition (CVD), the reactor comprises a reactor body that can be rotated around an axis with the help of a rotating appliance operatively arranged to the reactor, at least one sidewall that surrounds the reactor body, at least one inlet for reaction gas, at least one outlet for residual gas and at least one heat appliance operatively arranged to the reactor. The reactor is characterised in
10 that it comprises a layer of particles on the inside of the, at least, one side wall during operation for the manufacture of silicon by CVD.

It is an advantage that the reactor rotates during operation and it is an advantage that the layer of particles comprises loose particles, at least nearest
15 the reactor body. It is most preferred that the whole, or part of, the particle layer, in particular nearest the reactor body, comprises loose particles. Thereby, solid silicon is chemically vapour deposited on the layer of particles during operation, with the sidewall with the layer of particles being held at CVD conditions, and it is thereby easier to take out the solid silicon. Loose particles in the layer are
20 held in place by the rotation of the reactor or more particularly, by the centripetal forces. A layer comprising loose particles against the reactor body and the deposited solid silicon ensures a simple removal of the produced silicon. The outer part, or the whole layer can comprise a layer of bound particles as long as the layer leads to a simpler removal of produced silicon than without the layer,
25 in that the layer is weakly bound and breaks up easily, said layer is described as an easily broken up particle layer.

With the Dynatec reactor, if the reactor shall be re-used, it can be a challenge to remove the completed block of silicon from the reactor after so much silicon has
30 been deposited inside the reactor that it is not appropriate to continue the process for the manufacture of silicon. The block of deposited silicon must then be removed before the process can be started up again. With the present

invention the silicon will come off the inner wall of the reactor easily because the layer of particles functions as a ball-bearing layer or a gliding layer from where the block of silicon can be taken out more easily. Thereby, the advantage is that the production process can be operated much more continuously, which
5 reduces the production costs.

The reactor can comprise a pipe section or be assembled by several sidewalls or sections, preferably so that the reactor can be opened easily or the block of silicon can be extruded out. The cross section of the reactor body orthogonally
10 to the axis is preferably circular, but not necessarily, however it is preferably circular, with the layer of particles on the sidewall in an operation mode, with rotation and heating for the manufacture of silicon by CVD, to achieve the optimal operating conditions. In more detail particles are fed in or material is arranged in the reactor so that the centripetal acceleration arranges the particle
15 layer so that a circular cross section is achieved. With the term layer of particles one means the material which is, or during the operating conditions becomes, particulate so that the produced block of silicon can be taken out of the reactor easily. The material can be fed in as a solid, a liquid or a semiliquid. Thereby, the term layer of particles also comprises deposits or material which during
20 heating and rotation of the reactor intentionally break up to particulate material, shell fragments, fibres or other forms that give the intended gliding effect which makes taking out the produced blocks of silicon simpler.

The reactor does not necessarily have to have a top and a bottom, as one of or
25 both the top and bottom can be external parts, for example, a rotation table and a top that can be folded in a rotation appliance and which rotates in the same direction. There is only, at least, one sidewall that surrounds the reactor body which is obligatory, top and bottom can therefore be external components, which represents a preferred embodiment of the reactor according to the
30 invention.

The layer of particles preferably comprises material which contaminates the produced silicon to the smallest extent possible, it is preferred that the particles of silicon are of a metallurgical quality or purer, most preferred is silicon of the same purity as the silicon that is chemically vapour deposited. It is an
5 advantage that the layer of particles comprises, at least over a part of the thickness, for example, over the thickness of at least three median particle diameters of, in the main, round particles, thereby to achieve a good ball-bearing functionality.

10 The reactor is preferably formed as a pipe section that can rotate about its own axis. Thereby, the reactor can have any orientation during operation, which can be very practical.

In a preferred embodiment the reactor is formed as a standing, conical pipe
15 section that can rotate around its longitudinal axis, with a circular inner cross section and the largest diameter at the upper end. Thereby, the sidewall of the reactor has a taper that can be adapted so that the particle layer lies naturally correct onto the inner sidewall of the reactor. In more detail, the force of gravity is balanced on the particles against the vertical component in the counter force
20 from the wall. For example, a typical reactor, with a 2-pole electro motor driven at 50 Hz with 3000 rotations per minute, rpm, will generate a centripetal acceleration of 1000 g on the particles, thus the centripetal acceleration is 1000 times the force of gravity. Thus, a balancing vertical component in the counter force is only 1/1000 and the taper can be found directly by finding the arctan of
25 1/1000. This is also the case for other speeds of rotation and different inner reactor diameters, as the angle can be adjusted so that the force of gravity and the vertical component of the counter force from the wall on the particles are balanced against each other.

30 In a preferred embodiment the reactor is formed with an outer layer of particles that is fastened to the sidewall of the reactor, for example, by sintering or fusing. The outer particle layer means longer from the centre axis than the inner

particle layer, i.e. innermost against the reactor wall. Thereby it is not only simpler to get a particle layer but it will be simpler to get a layer of coarser particles outermost, nearest the wall and finer particles with a larger surface area innermost against the reactor body. Thereby, the particles will not so easily
5 go through a separation over time so that it can be easier to achieve a layer with fine, non-contaminated particles with a large surface area innermost against the reactor body. Natural radial separation can otherwise lead to that coarse particles lie innermost and fine outermost against the wall of the reactor.

10 The reactor preferably comprises one outlet and at least one inlet at the same end, the inlet or the inlets are arranged concentrically outside the outlet. Thereby one end can be without perforations for simple placing on a rotating base and spent reaction gas, or residual gas or inert gas that can, for example, have a density 1/16 of the density of rich reaction gas, will be taken out at the
15 centre line where it will collect naturally, while rich reaction gas will be fed in nearer the sidewall where it collects naturally. In this way the flow pattern is improved. Alternatively, the inlet and the outlet can be at opposite ends so that the reactor is the through-flow reactor. One or more inlets can be arranged at the bottom and one or more outlets at the top, or vice versa.

20

In a preferred embodiment the reactor comprises several sub-volumes, for example, preferably cylindrical sub-volumes that sit fitted next to each other on, or along, a circle around the rotational axis of the reactor. This is an embodiment that has been tested and it had the advantage of having less
25 turbulence inside the reactor and simpler feeding out of smaller blocks of silicon after completion of the process.

The reactor preferably comprises a particle layer of silicon powder formed by operation of the reactor containing reaction gas for chemical vapour deposition
30 before the start-up of chemical vapour deposition for the production of solid silicon as will be explained in detail below.

The invention also provides a method for manufacture of silicon by chemical vapour deposition (CVD), preferably by the use of the reactor according to the invention. The method is characterised by producing a layer of particles from the reaction gas in the reactor and/or feed in particles for the formation of an inner layer of particles on the inner wall surface of the reactor, to feed in
5 reaction gas for chemical vapour deposition, to produce solid silicon by chemical vapour deposition on the particle layer, to loosen the produced silicon from the particle layer and to take it out and to carry out any preparation of the inner surface of the reactor before the production of silicon continues by
10 repeating the steps of the method.

The reactor is preferably kept warm when going through the steps of the method and in the rotation up to the step of the chemical vapour deposition, for efficient production.

15

A particle layer of silicon powder can advantageously be formed by the operation of the reactor containing reaction gas for chemical vapour deposition, preferably silane, before the start-up of chemical vapour deposition for production of solid silicon, by controlling the concentration and pressure of the
20 reaction gas and temperature and speed of rotation of the reactor, so that, in the main, only silicon powder (so-called "fines" of different types) amorphous and/or crystalline is produced. In more detail, and with silane at atmospheric pressure, for example, the formation of amorphous silicon powder starts at a temperature of 420 °C, at ca. 600-610 °C crystalline silicon powder is formed.
25 Previously formed amorphous silicon powder can be converted to crystalline silicon powder at the temperature where crystalline silicon powder is formed directly. Note that there can be parallel unwanted reactions, particularly at other temperatures than those mentioned and other pressures, and with other gases. Therefore, it must be tested if the conditions that have been mentioned should
30 be adjusted if the reactor contains gases other than silane.

The invention also provides an application of a reactor according to the invention for the manufacture of silicon by chemical vapour deposition (CVD).

The invention also provides the application of a loose and/or solid, easily
5 disintegrating particle layer on the inner reactor wall in a reactor for chemical vapour deposition (CVD) of silicon for a simpler removal of the produced silicon from the reactor. Note that the embodiment of a solid, easily disintegrating particle layer is also valid for reactors that do not rotate.

10 The particle layer can comprise small and/or large particles that are hollow, compact or porous or with varying porosity in the form of a dust, powder, sand, small balls or other small particles that are placed or settle as a thin layer on the inside of the reactor or the inner wall of the container. It is an advantage to
15 place or spray a thin layer of powder, small balls or other small particles on the inside of the reactor wall. The centripetal forces that arise in the rotating reactor container will hold the particles in place on the wall at the same time as they will help to form a layer with a circular inner cross section. The particles are distributed evenly over the inner wall of the reactor cylinder by the centripetal force after the reactor has been made to rotate.

20

The particles ought to be of a material that leads to very little contamination and does not fuse together or stick to each other at the operating temperature of the reactor. Particles of pure silicon are most preferred, but silicon nitride and quartz are good alternatives. Commercial access to sand/particles of these materials is
25 good and this will therefore be a cheaper alternative than reactors manufactured with a wall of a pipe section in the same material. By the use of super pure, fine silicon sand, at least innermost against the reactor body, the post-processing of the silicon block will be very simple as there is no need to remove a layer of a different material outermost on the block of silicon. Particles
30 of different sizes and shapes can be used. The layer can comprise several tiers of different types of particles. It is preferred that the particles innermost against the reactor wall will have a size and shape that leads to a good slip when the

block of silicon shall be taken out of the reactor, while the particles nearest the reactor body shall be suitable as a deposit surface for deposition of silicon.

The reactor according to the invention can comprise the features that are
5 described here or illustrated in any operative combination, every such
combination is an embodiment of the present invention. The method according
to the invention can comprise features or steps that are described here or
illustrated in any operative combination, every such combination is an
embodiment of the present invention.

10

Although it is very much preferred that the reactor rotates during operation with
chemical vapour deposition of solid silicon, and also during the formation of the
particle layer of fine silicon powder, the rotation is not obligatory if the particle
layer is solid but is loosely attached, that means the layer is easily broken up so
15 that the silicon produced can easily be taken out of the reactor. The use of a
solid, lightly bound, and thereby easily disintegrating layer of particles on the
inner surface of a reactor for chemical vapour deposition of silicon to simplify
the removal of solid silicon produced by chemical vapour deposition on the
particle layer has not been known previously, the invention therefore contributes
20 to simplified production also for reactors that do not rotate during production.
For the particle layer which is completely or partially loose the reactor must, of
course, be rotated during production such that the layer is held in place by the
centripetal force.

25 Figures

Some embodiments of the invention are illustrated in the figures, in which
Figure 1 illustrates a section of a circular reactor container with a layer of
particles and the silicon depositing initiated,
Figure 2 illustrates a tiered particle layer with particles of different sizes and
30 shapes, and
Figure 3 illustrates a particle layer put on at an angle and/or put on a tilted
reactor wall.

Detailed description

Reference is made to Figure 1. The reactor comprises, in the main, a container (2), preferably formed as a cylinder with a circular, or approximately circular
5 cross section, with an inlet for gas at the one end and an outlet at the other end or same end, and with the supply of heat on the outside and possibly on the inside too. The reactor is operatively arranged to an appliance to set the reactor in rotation (10), such as a motor. The particles (1) are distributed over the inner wall (4) of the reactor container (2) after it has been made to rotate (10) so that
10 there will be an even layer of particles on the whole of the reactor wall (4). Thereby, the particles (1) will lie as a layer of particles (6) on the inside (4) of the reactor tube (2) and appear as an inner tube in the reactor container (2). The silicon deposits (3) will first be formed on the inside (5) of the particle layer (6).

15 The particles (1) can be in the form of sand, dust or small balls in a hollow, porous or compact form, preferably of a material that leads to very little contamination. Examples of preferred materials are quartz and silicon nitride, but most preferred will be particles of sand or dust of super pure crystalline silicon.
20 The deposits (3) of silicon will start on the inside (5) of the particle layer (6) so that the particle layer (6) remains lying between the reactor wall (2) and the silicon deposits (3). The inside (5) of the particle layer (6) comes in direct contact with the silicon deposits (3) and it is therefore important that the particle layer (6) does not contaminate the silicon (3). The particle layer (6) of a non-
25 contaminating material will act as a barrier against contamination from the reactor wall (2) and all other materials and matter lying outside. In addition to that the particle layer (6) ensures that there is no direct contact between the silicon deposits (3) and the inside (4) of the reactor container (2) the large centripetal forces at the reactor wall (4) generated by the rotation (10) will work
30 against diffusion of material in towards the silicon deposits (3). Therefore, a particle layer (6) with non-contaminating particles (1) on the inside (4) of the rotating (10) reactor container (2) will lead to very pure silicon deposits (3).

The particle layer (6) should preferentially be put onto the inside (4) of the reactor container (2) after the reactor has started to rotate (10). The particles (1) can be sprayed onto the reactor wall (4) and the thickness and form can be
5 adjusted afterwards by going down with a tool that touches the particle layer (6) according to the principle of a lathe. The centripetal force will ensure that the particles (1) remain on the reactor wall (4). The same force will also ensure that the particles (1) distribute themselves evenly over the reactor wall (4). The particles (1) can have different sizes and shapes, either as dust, sand or small
10 balls.

Reference is made to Figure 2. The particles can be put on in a tiered fashion (9), with x number of layers of particles of a similar or different material and/or sizes and shapes in every tier, preferably with particles (1) with a round ball
15 shape or approximate round ball shape against the reactor wall (4) and smaller particles (1) against the silicon deposits (5). This will be preferred when a completed block of silicon shall be taken out of the reactor. The ball formed particles against the reactor wall (4) will function as a ball-bearing between the block of silicon (3) and the reactor wall (4). Another preferential putting on of the
20 particle layer (6), illustrated in Figure 3, is to put on the particle layer at an angle (8) and/or on a slanting (7) reactor wall (4). This can provide a favourable effect when the block of silicon (3) shall be taken out, in that the block of silicon (3) will have a taper (7 and 8) from the reactor wall (4) and the particle layer (6).
Particles (1) that are deformed or crushed when exposed to a certain pressure
25 can also be advantageous to take up expansion from heat and simplify the taking out of the block of silicon.

When the particle layer (1) is distributed over the reactor wall (4) the CVD process can start. A silicon-containing reaction gas (11) is fed into the reactor
30 through an inlet at the one end of the reactor. The reaction gas (11) is forced outwards towards the particle layer (6) by the centripetal forces, where it is heated up to above the decomposition temperature. Super pure silicon (3) is

then deposited on the inside (5) of the layer of particles so that the reactor body gradually becomes overgrown. The process is stopped when the reactor body is blocked by growth, or until there is no purpose in continuing to run the reactor any further. The supply of reaction gas (11) and the block of silicon (3) is taken
5 out. A new particle layer (6) is put on and the process can start up again. With the use of silicon sand in the particle layer (6) nearest the silicon deposits (5) the need for processing of the finished block of silicon will be less.

Claims

1.

Reactor for the manufacture of silicon by chemical vapour deposition (CVD), the
5 reactor comprises a reactor body that can rotate around an axis with the help of
a rotation device operatively arranged to the reactor, at least one sidewall that
surrounds the reactor body, at least one inlet for reaction gas, at least one outlet
for residual gas and at least one heat appliance operatively arranged to the
reactor, **characterised in that** during operation for the manufacture of silicon by
10 CVD, the reactor comprises a layer of particles on the inside of, at least, one
side wall.

2.

Reactor according to claim 1, characterised in that the layer of particles
15 comprises material which, to the smallest extent possible, contaminates the
produced silicon, the particles of silicon are preferably of a metallurgic quality or
purer, most preferably silicon of the same purity as the silicon which is
chemically vapour deposited.

20 3.

Reactor according to claim 1 or 2, characterised in that the layer of particles, at
least across a part of the thickness, is comprised of, in the main, round
particles.

25 4.

Reactor according to claims 1-3, characterised in that it is shaped as a pipe
section, which is rotary around its own axis.

5.

30 Reactor according to claims 1-4, characterised in that it is formed as a standing
conical pipe section that can rotate about the longitudinal axis, with a circular
inner cross section and the largest diameter at an upper end.

6.

Reactor according to claims 1-5, characterised in that it is formed with an outer particle layer which is fastened to the sidewall of the reactor.

5

7.

Reactor according to claims 1-6, characterised in that it comprises an outlet and at least one inlet at the same end, the inlet or the inlets are arranged concentrically outside the outlet.

10

8.

Reactor according to claims 1-7, characterised in that it comprises a particle layer of silicon powder formed by operating the reactor containing reaction gas for chemical vapour deposition before the chemical vapour deposition is initiated.

15

9.

Method for the manufacture of silicon by chemical vapour deposition (CVD), preferably by the use of the reactor according to the claims 1-8, **characterised** **by** producing a particle layer from the reaction gas in the reactor or importing particles for the formation of an inner particle layer on the inner wall surface of the reactor, importing reaction gas for chemical vapour deposition, producing silicon by chemical vapour deposition on the particle layer, loosening the produced silicon from the particle layer and taking it out and carrying out any preparation of the inner surface of the reactor before the production of the silicon is continued by repeating the steps of the method.

20

25

10.

Method according to claim 8, characterised in that the reactor is kept warm during the carrying out of the method steps and in rotation up to the step for chemical vapour deposition.

30

11.

Method according to claim 9 or 10, characterised in that a particle layer of silicon powder is formed during the operation of the reactor containing reaction gas for chemical vapour deposition, preferably silane, before starting up the chemical vapour deposition, by control of the concentration and pressure of the
5 reaction gas, temperature and speed of rotation of the reactor so that, in the main, only silicon powder, amorphous and/or crystalline, is formed.

12.

10 Application of a reactor according to any of the claims 1-8 for the manufacture of silicon by chemical vapour deposition (CVD).

13.

15 Application of a loose or easily disintegrating particle layer on the inner reactor wall in a reactor for chemical vapour deposition (CVD) of silicon, to simplify the removal of produced silicon from the reactor.

FIG. 1

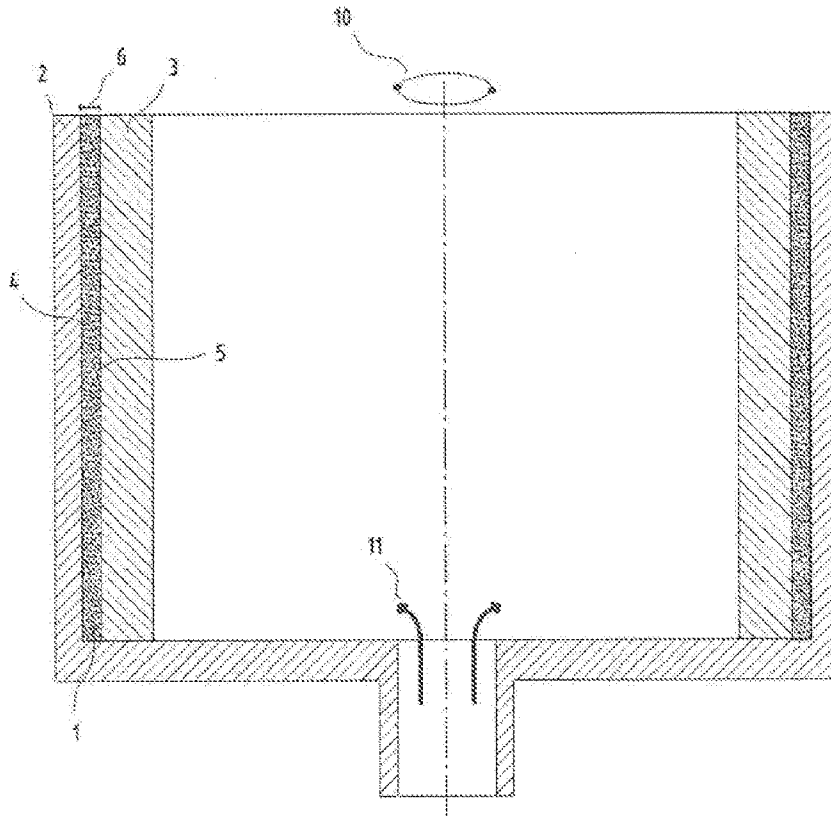


FIG. 2

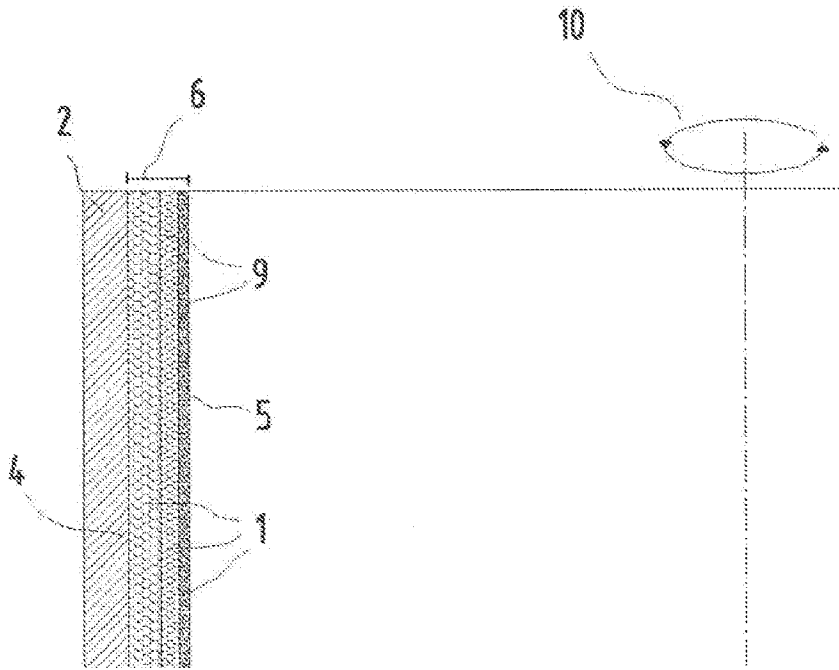
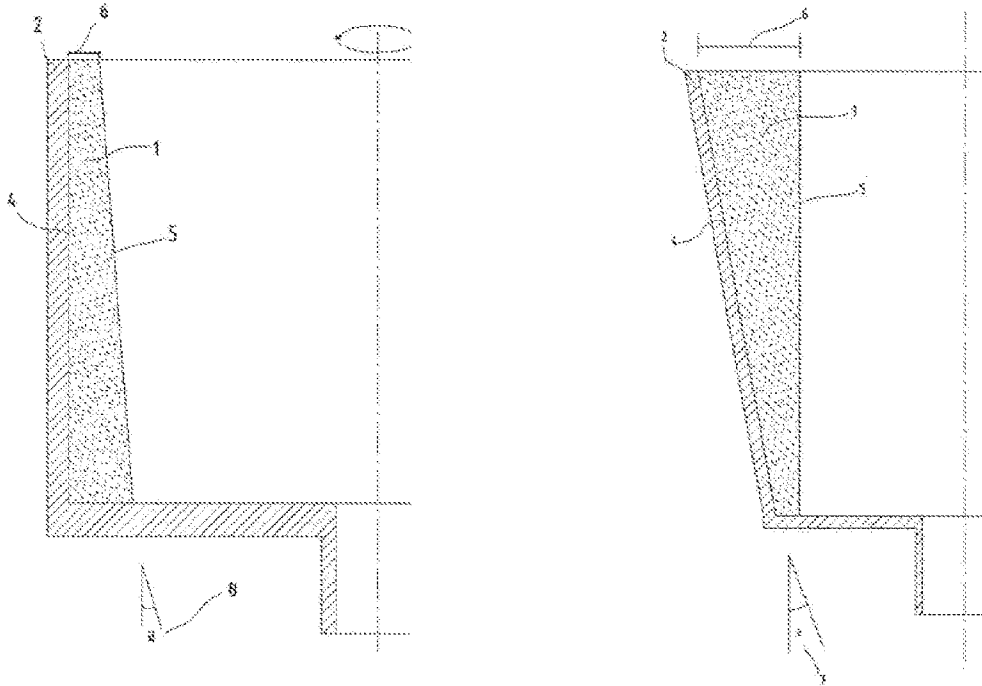


FIG. 3



INTERNATIONAL SEARCH REPORT

International application No.

PCT/NO2012/050184

A. CLASSIFICATION OF SUBJECT MATTER C01B 33/027 (2006.01), C01B 33/029 (2006.01), C01B 33/03 (2006.01), C01B 33/035 (2006.01), C23C 16/01 (2006.01), C23C 16/24 (2006.01) According to International Patent Classification (IPC) or to both national classification and IPC		
B. FIELDS SEARCHED Minimum documentation searched (classification system followed by classification symbols) C01B, C23C, C30B Documentation searched other than minimum documentation to the extent that such documents are included in the fields searched NO, SE, DK, FI, classes as above Electronic data base consulted during the international search (name of data base and, where practicable, search terms used) EPODOC, WPI, CAPLUS, FULL TEXT: ENGLISH, GERMAN, FRENCH, NPL		
C. DOCUMENTS CONSIDERED TO BE RELEVANT		
Category*	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
X	WO 2011/065839 A1 (DYNATEC ENGINEERING AS) 2011.06.03 page 3, l. 16 - page 5, l. 12, page 8, l. 32 - page 9, l. 15, page 11, l. 23-26, and page 14, l. 11-17	1-4, 6, 8, 12
Y	---	5, 10
X	WO 2010/136529 A1 (DYNATEC ENGINEERING AS) 2010.12.02 page 2, l. 31 - page 3, l. 27	1-4, 6, 12
X	US 2008/0213156 A1 (JOINT SOLAR SILICON GMBH & CO) 2008.09.04 [0007], [0013-0016]	1-4, 6, 9, 12, 13
Y	---	10
X	JP 2004-18369 A (KAMAIKE YUTAKA; YAMASE HIDEO) 2004.01.22, english abstract WPI AN 2004-184506	1, 2, 9, 12, 13
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Date of the actual completion of the international search	Date of mailing of the international search report	
20/12/2012	21 December 2012	
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